



+3V/+5V, Serial-Input, Voltage-Output, 16-Bit DACs

MAX5441-MAX5444

General Description

The MAX5441–MAX5444 are serial-input, voltage-output, 16-bit digital-to-analog converters (DACs) in tiny μ MAX[®] packages, 50% smaller than comparable DACs in 8-pin SOs. They operate from low +3V (MAX5443/MAX5444) or +5V (MAX5441/MAX5442) single supplies. They provide 16-bit performance (± 2 LSB INL and ± 1 LSB DNL) over temperature without any adjustments. Unbuffered DAC outputs result in a low supply current of 120 μ A and a low offset error of 2LSB.

The DAC output ranges from 0 to V_{REF} . For bipolar operation, matched scaling resistors are provided in the MAX5442/MAX5444 for use with an external precision op amp (such as the MAX400), generating a $\pm V_{REF}$ output swing.

A 16-bit serial word is used to load data into the DAC latch. The 25MHz, 3-wire serial interface is compatible with SPI™/QSPI™/MICROWIRE™, and can interface directly with optocouplers for applications requiring isolation. A power-on reset circuit clears the DAC output to code 0 (MAX5441/MAX5443) or code 32768 (MAX5442/MAX5444) when power is initially applied.

A logic low on \overline{CLR} asynchronously clears the DAC output to code 0 (MAX5441/MAX5443) or code 32768 (MAX5442/MAX5444) independent of the serial interface.

The MAX5441/MAX5443 are available in 8-pin μ MAX packages. The MAX5442/MAX5444 are available in 10-pin μ MAX packages.

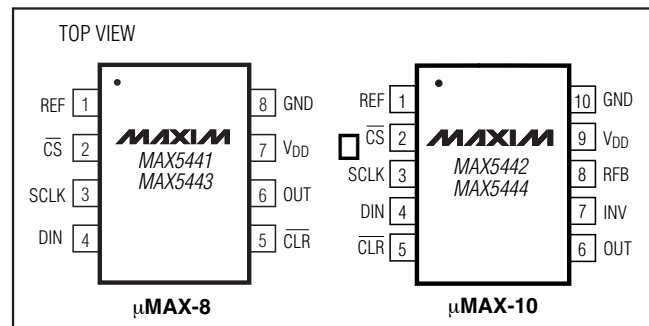
Applications

High-Resolution Offset and Gain Adjustment
Industrial Process Control
Automated Test Equipment
Data-Acquisition Systems

Features

- ◆ Ultra-Small 3mm x 5mm 8-Pin μ MAX Package
- ◆ Low 120 μ A Supply Current
- ◆ Fast 1 μ s Settling Time
- ◆ 25MHz SPI/QSPI/MICROWIRE-Compatible Serial Interface
- ◆ V_{REF} Range Extends to V_{DD}
- ◆ +5V (MAX5441/MAX5442) or +3V (MAX5443/MAX5444) Single-Supply Operation
- ◆ Full 16-Bit Performance Without Adjustments
- ◆ Unbuffered Voltage Output Directly Drives 60k Ω Loads
- ◆ Power-On Reset Circuit Clears DAC Output to Code 0 (MAX5441/MAX5443) or Code 32768 (MAX5442/MAX5444)
- ◆ Schmitt-Trigger Inputs for Direct Optocoupler Interface
- ◆ Asynchronous \overline{CLR}

Pin Configurations



Functional Diagrams appear at end of data sheet.

Ordering Information

| PART | TEMP RANGE | PIN-PACKAGE | INL (LSB) | SUPPLY (V) |
|-------------|----------------|--------------|-----------|------------|
| MAX5441ACUA | 0°C to +70°C | 8 μ MAX | ± 2 | 5 |
| MAX5441AEUA | -40°C to +85°C | 8 μ MAX | ± 2 | 5 |
| MAX5441BCUA | 0°C to +70°C | 8 μ MAX | ± 4 | 5 |
| MAX5441BEUA | -40°C to +85°C | 8 μ MAX | ± 4 | 5 |
| MAX5442ACUB | 0°C to +70°C | 10 μ MAX | ± 2 | 5 |
| MAX5442AEUB | -40°C to +85°C | 10 μ MAX | ± 2 | 5 |
| MAX5442BCUB | 0°C to +70°C | 10 μ MAX | ± 4 | 5 |
| MAX5442BEUB | -40°C to +85°C | 10 μ MAX | ± 4 | 5 |

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SPI and QSPI are trademarks of Motorola, Inc.
MICROWIRE is a trademark of National Semiconductor Corp.

Ordering Information continued at end of data sheet.



Maxim Integrated Products 1

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ABSOLUTE MAXIMUM RATINGS

| | |
|--|------------------------------|
| V_{DD} to GND | -0.3V to +6V |
| \overline{CS} , SCLK, DIN, \overline{CLR} to GND | -0.3V to +6V |
| REF to GND | -0.3V to ($V_{DD} + 0.3V$) |
| OUT, INV to GND | -0.3V to V_{DD} |
| RFB to INV | -6V to +6V |
| RFB to GND | -6V to +6V |
| Maximum Current Into Any Pin | 50mA |

| | |
|--|---|
| Continuous Power Dissipation ($T_A = +70^\circ\text{C}$) | |
| 8-Pin μMAX (derate 4.5mW/ $^\circ\text{C}$ above $+70^\circ\text{C}$) | 362mW |
| 10-Pin μMAX (derate 5.6mW/ $^\circ\text{C}$ above $+70^\circ\text{C}$) | 444mW |
| Operating Temperature Ranges | |
| MAX544 _CU_ | 0°C to $+70^\circ\text{C}$ |
| MAX544 _EU_ | -40°C to $+85^\circ\text{C}$ |
| Storage Temperature Range | -65°C to $+150^\circ\text{C}$ |
| Maximum Die Temperature | $+150^\circ\text{C}$ |
| Lead Temperature (soldering, 10s) | $+300^\circ\text{C}$ |

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

($V_{DD} = +3V$ (MAX5443/MAX5444) or $+5V$ (MAX5441/MAX5442), $V_{REF} = +2.5V$, $C_L = 10\text{pF}$, $GND = 0$, $R_L = \infty$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted. Typical values are at $T_A = +25^\circ\text{C}$.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|---|-----------|---|-----|------------|-------------|-----------------------|
| STATIC PERFORMANCE—ANALOG SECTION | | | | | | |
| Resolution | N | | 16 | | | Bits |
| Differential Nonlinearity | DNL | Guaranteed monotonic | | ± 0.5 | ± 1 | LSB |
| Integral Nonlinearity | INL | MAX544_A | | ± 0.5 | ± 2 | LSB |
| | | MAX544_B | | ± 0.5 | ± 4 | |
| Zero-Code Offset Error | ZSE | | | | ± 2 | LSB |
| Zero-Code Tempco | ZSTC | | | ± 0.05 | | ppm/ $^\circ\text{C}$ |
| Gain Error (Note 1) | | | | | ± 10 | LSB |
| Gain-Error Tempco | | | | ± 0.1 | | ppm/ $^\circ\text{C}$ |
| DAC Output Resistance | R_{OUT} | (Note 2) | | 6.2 | | $k\Omega$ |
| Bipolar Resistor Matching | | R_{FB}/R_{INV} | | 1 | | % |
| | | Ratio error | | | ± 0.015 | |
| Bipolar Zero Offset Error | | | | | ± 20 | LSB |
| Bipolar Zero Tempco | BZSTC | | | ± 0.5 | | ppm/ $^\circ\text{C}$ |
| Power-Supply Rejection | PSR | $+2.7V \leq V_{DD} \leq +3.3V$ (MAX5443/MAX5444) | | | ± 1 | LSB |
| | | $+4.5V \leq V_{DD} \leq +5.5V$ (MAX5441/MAX5442) | | | ± 1 | |
| REFERENCE INPUT | | | | | | |
| Reference Input Range | V_{REF} | (Note 3) | 2.0 | | V_{DD} | V |
| Reference Input Resistance (Note 4) | R_{REF} | Unipolar mode | 10 | | | $k\Omega$ |
| | | Bipolar mode | 6 | | | |
| DYNAMIC PERFORMANCE—ANALOG SECTION | | | | | | |
| Voltage-Output Slew Rate | SR | (Note 5) | | 15 | | V/ μs |
| Output Settling Time | | To $\pm 1/2$ LSB of FS | | 1 | | μs |
| DAC Glitch Impulse | | Major-carry transition | | 7 | | nV-s |
| Digital Feedthrough | | Code = 0000 hex; $\overline{CS} = V_{DD}$; SCLK, DIN = 0 to V_{DD} levels | | 0.2 | | nV-s |

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MAX5441-MAX5444

ELECTRICAL CHARACTERISTICS (continued)

($V_{DD} = +3V$ (MAX5443/MAX5444) or $+5V$ (MAX5441/MAX5442), $V_{REF} = +2.5V$, $C_L = 10pF$, $GND = 0$, $R_L = \infty$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted. Typical values are at $T_A = +25^\circ C$.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|--|-------------|---|-----------------|------|---------|-------------------|
| DYNAMIC PERFORMANCE—REFERENCE SECTION | | | | | | |
| Reference -3dB Bandwidth | BW | Code = FFFF hex | | 1 | | MHz |
| Reference Feedthrough | | Code = 0000 hex, $V_{REF} = 1V_{P-P}$ at 100kHz | | 1 | | mV _{P-P} |
| Signal-to-Noise Ratio | SNR | | | 92 | | dB |
| Reference Input Capacitance | C_{INREF} | Code = 0000 hex | | 70 | | pF |
| | | Code = FFFF hex | | 170 | | |
| STATIC PERFORMANCE—DIGITAL INPUTS | | | | | | |
| Input High Voltage | V_{IH} | | 2.4 | | | V |
| Input Low Voltage | V_{IL} | | | | 0.8 | V |
| Input Current | I_{IN} | | | | ± 1 | μA |
| Input Capacitance | C_{IN} | (Note 6) | | 3 | 10 | pF |
| Hysteresis Voltage | V_H | | | 0.15 | | V |
| POWER SUPPLY | | | | | | |
| Positive Supply Range (Note 7) | V_{DD} | MAX5443/MAX5444 | 2.7 | | 3.6 | V |
| | | MAX5441/MAX5442 | 4.5 | | 5.5 | |
| Positive Supply Current | I_{DD} | All digital inputs at V_{DD} or GND | | 0.12 | 0.20 | mA |
| Power Dissipation | PD | All digital inputs at V_{DD} or GND | MAX5443/MAX5444 | 0.36 | | mW |
| | | | MAX5441/MAX5442 | 0.60 | | |

TIMING CHARACTERISTICS

($V_{DD} = +2.7V$ to $+3.3V$ (MAX5443/MAX5444), $V_{DD} = +4.5V$ to $+5.5V$ (MAX5441/MAX5442), $V_{REF} = +2.5V$, $GND = 0$, CMOS inputs, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted. Typical values are at $T_A = +25^\circ C$.) (Figure 1)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|---|------------|------------|-----|-----|-----|---------|
| SCLK Frequency | f_{CLK} | | | | 25 | MHz |
| SCLK Pulse Width High | t_{CH} | | 20 | | | ns |
| SCLK Pulse Width Low | t_{CL} | | 20 | | | ns |
| \overline{CS} Low to SCLK High Setup | t_{CSS0} | | 15 | | | ns |
| \overline{CS} High to SCLK High Setup | t_{CSS1} | | 15 | | | ns |
| SCLK High to \overline{CS} Low Hold | t_{CSH0} | (Note 6) | 35 | | | ns |
| SCLK High to \overline{CS} High Hold | t_{CSH1} | | 20 | | | ns |
| DIN to SCLK High Setup | t_{DS} | | 15 | | | ns |
| DIN to SCLK High Hold | t_{DH} | | 0 | | | ns |
| \overline{CLR} Pulse Width Low | t_{CLW} | | 20 | | | ns |
| V_{DD} High to \overline{CS} Low (power-up delay) | | | | 20 | | μs |

Note 1: Gain error tested at $V_{REF} = +2.0V$, $+2.5V$, and $+3.0V$ (MAX5443/MAX5444) or $V_{REF} = +2.0V$, $+2.5V$, $+3.0V$, and $+5.5V$ (MAX5441/MAX5442).

Note 2: R_{OUT} tolerance is typically $\pm 20\%$.

Note 3: Min/max range guaranteed by gain-error test. Operation outside min/max limits will result in degraded performance.

Note 4: Reference input resistance is code-dependent, minimum at 8555hex in unipolar mode, 4555hex in bipolar mode.

Note 5: Slew-rate value is measured from 10% to 90%.

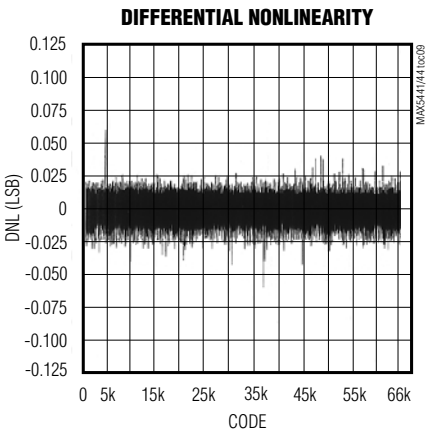
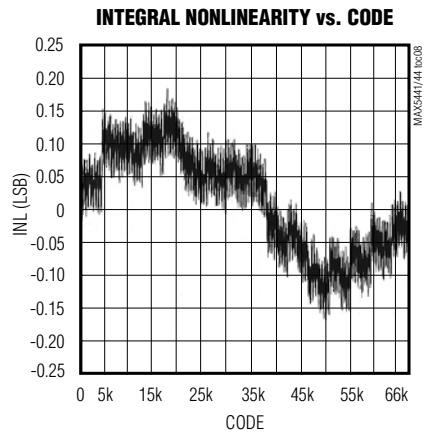
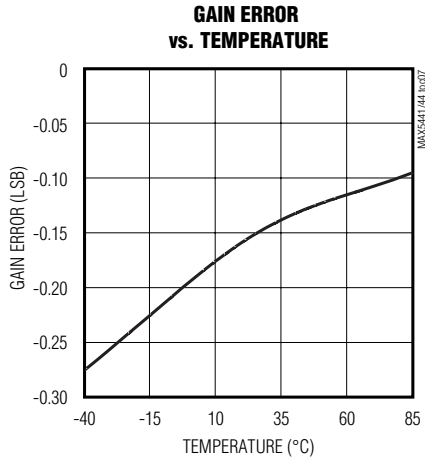
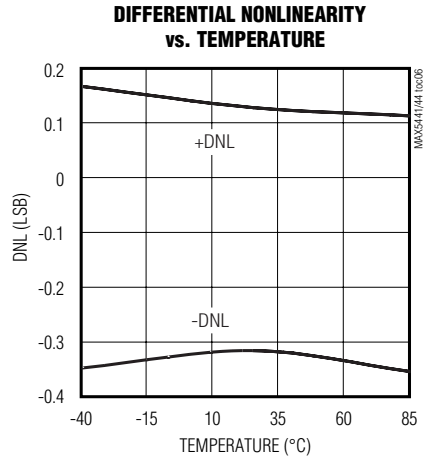
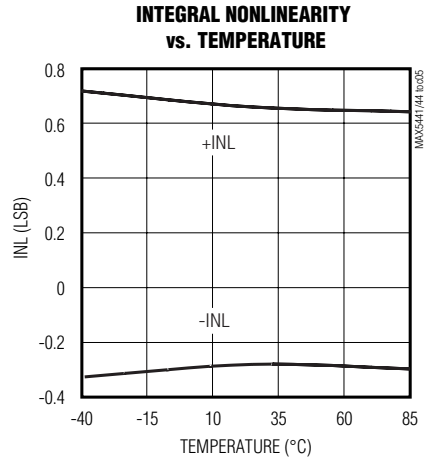
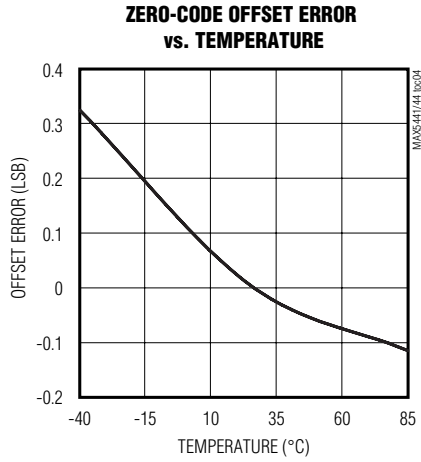
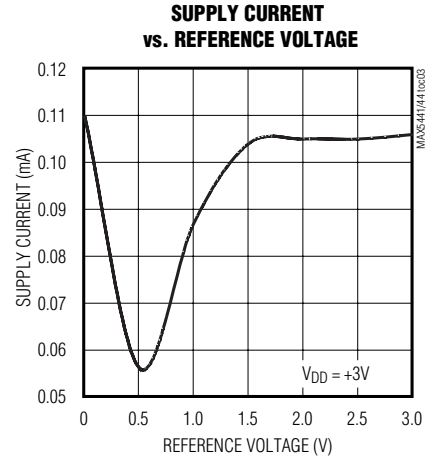
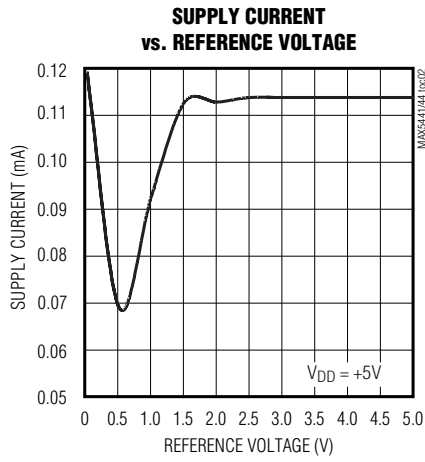
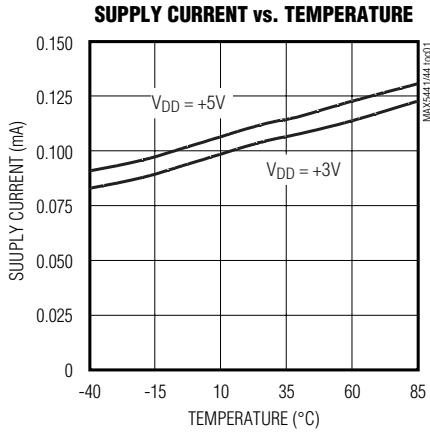
Note 6: Guaranteed by design. Not production tested.

Note 7: Guaranteed by power-supply rejection test and *Timing Characteristics*.

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Typical Operating Characteristics

($V_{DD} = +3V$ (MAX5443/MAX5444) or $+5V$ (MAX5441/MAX5442), $V_{REF} = +2.5V$, $GND = 0$, $R_L = \infty$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted. Typical values are at $T_A = +25^\circ C$.)

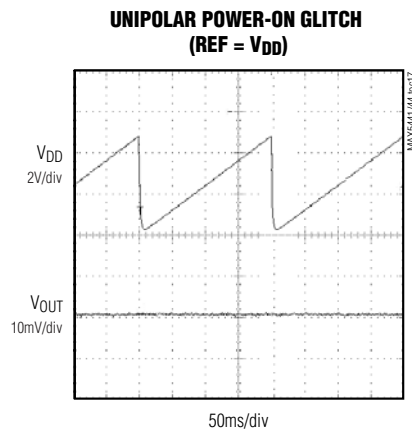
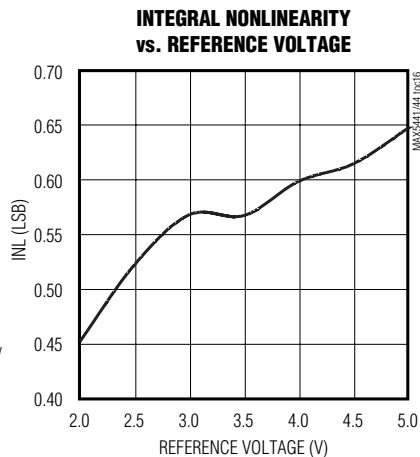
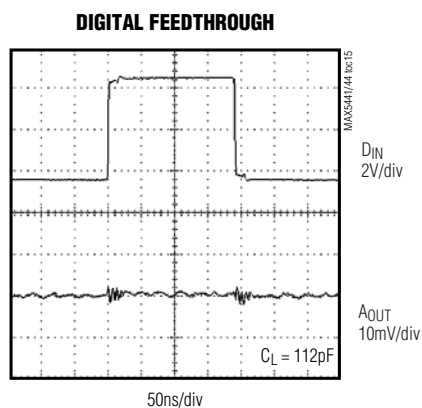
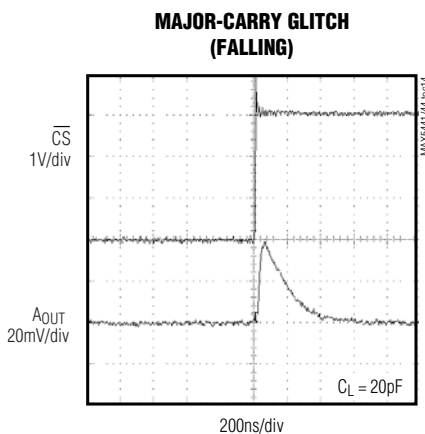
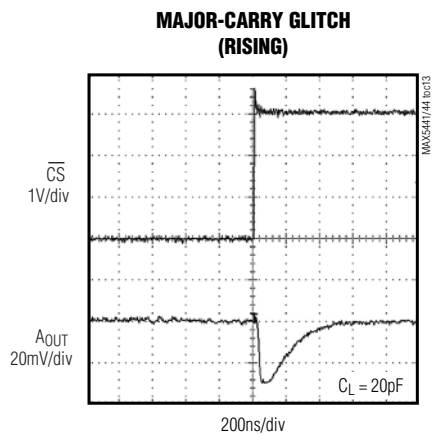
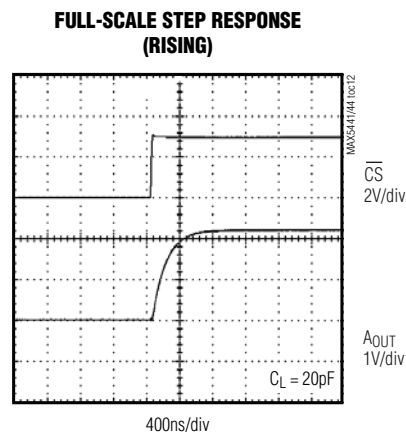
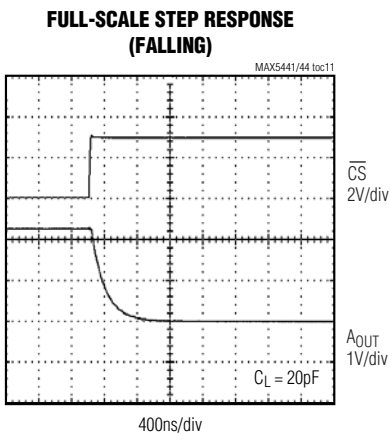
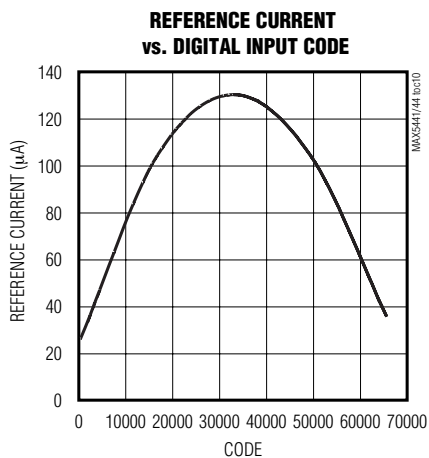


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MAX5441-MAX5444

Typical Operating Characteristics (continued)

($V_{DD} = +3V$ (MAX5443/MAX5444) or $+5V$ (MAX5441/MAX5442), $V_{REF} = +2.5V$, $GND = 0$, $R_L = \infty$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted. Typical values are at $T_A = +25^\circ C$.)



+3V/+5V, Serial-Input, Voltage-Output, 16-Bit DACs

Pin Description

| PIN | | NAME | FUNCTION |
|--------------------|--------------------|------------------|---|
| MAX5441 MAX5443 | MAX5442 MAX5444 | | |
| 1 | 1 | REF | Voltage Reference Input |
| 2 | 2 | \overline{CS} | Chip-Select Input |
| 3 | 3 | SCLK | Serial Clock Input. Duty cycle must be between 40% and 60%. |
| 4 | 4 | DIN | Serial Data Input |
| 5 | 5 | \overline{CLR} | Clear Input. Logic low asynchronously clears the DAC to code 0 (MAX5441/MAX5443) or code 32768 (MAX5442/MAX5444). |
| 6 | 6 | OUT | DAC Output Voltage |
| — | 7 | INV | Junction of Internal Scaling Resistors. Connect to external op amp's inverting input in bipolar mode. |
| — | 8 | RFB | Feedback Resistor. Connect to external op amp's output in bipolar mode. |
| 7 | 9 | V _{DD} | Supply Voltage. Use +3V for MAX5443/MAX5444 and +5V for MAX5441/MAX5442. |
| 8 | 10 | GND | Ground |

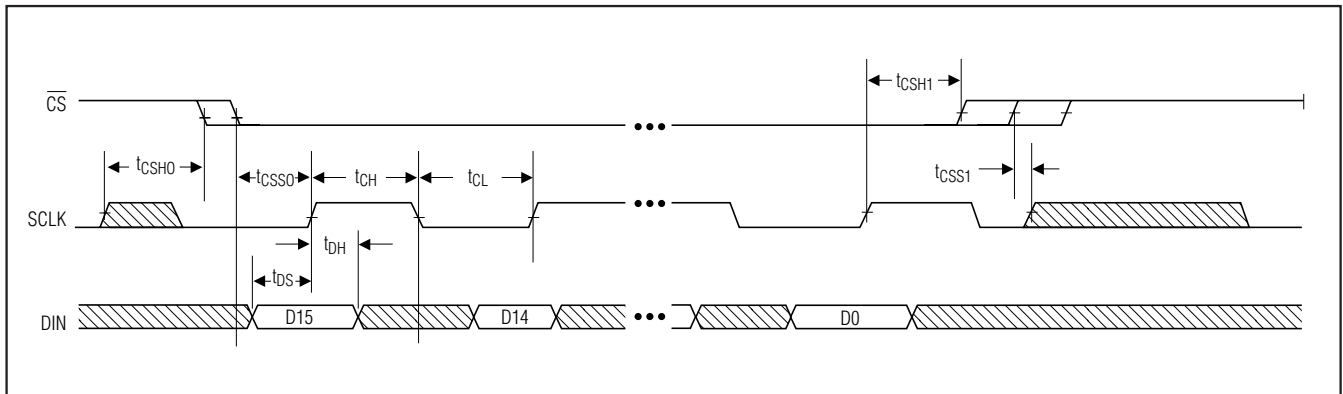


Figure 1. Timing Diagram

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MAX5441-MAX5444

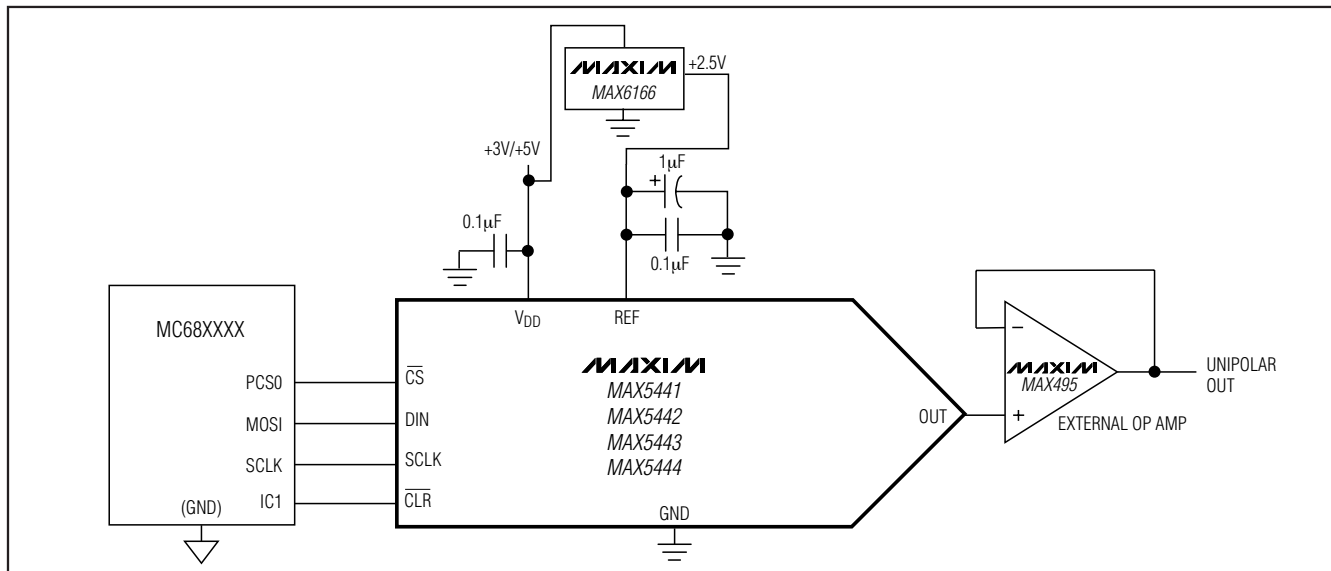


Figure 2a. Typical Operating Circuit—Unipolar Output

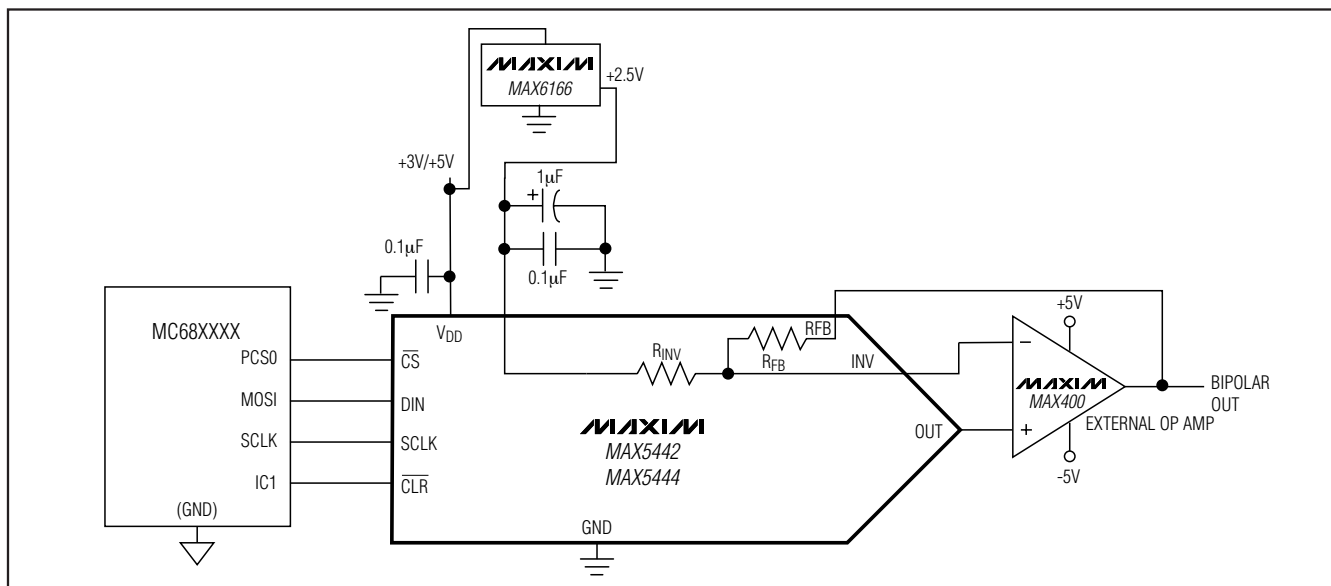


Figure 2b. Typical Operating Circuit—Bipolar Output

Detailed Description

The MAX5441-MAX5444 voltage-output, 16-bit digital-to-analog converters (DACs) offer full 16-bit performance with less than 2LSB integral linearity error and less than 1LSB differential linearity error, thus ensuring monotonic performance. Serial data transfer minimizes the number of package pins required.

The MAX5441-MAX5444 are composed of two matched DAC sections, with a 12-bit inverted R-2R DAC forming the 12 LSBs and the four MSBs derived from 15 identically matched resistors. This architecture allows the lowest glitch energy to be transferred to the DAC output on major-carry transitions. It also lowers the DAC output impedance by a factor of eight compared

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to a standard R-2R ladder, allowing unbuffered operation in medium-load applications.

The MAX5442/MAX5444 provide matched bipolar offset resistors, which connect to an external op amp for bipolar output swings (Figure 2b).

Digital Interface

The MAX5441–MAX5444 digital interface is a standard 3-wire connection compatible with SPI/QSPI/MICROWIRE interfaces. The chip-select input (\overline{CS}) frames the serial data loading at the data-input pin (DIN). Immediately following \overline{CS} 's high-to-low transition, the data is shifted synchronously and latched into the input register on the rising edge of the serial clock input (SCLK). After 16 data bits have been loaded into the serial input register, it transfers its contents to the DAC latch on \overline{CS} 's low-to-high transition (Figure 3). Note that if \overline{CS} is not kept low during the entire 16 SCLK cycles, data will be corrupted. In this case, reload the DAC latch with a new 16-bit word.

Clearing the DAC

A 20ns (min) logic-low pulse on \overline{CLR} asynchronously clears the DAC buffer to code 0 in the MAX5441/MAX5443 and to code 32768 in the MAX5442/MAX5444.

External Reference

The MAX5441–MAX5444 operate with external voltage references from 2V to V_{DD} . The reference voltage determines the DAC's full-scale output voltage.

Power-On Reset

The power-on reset circuit sets the output of the MAX5441/MAX5443 to code 0 and the output of the

MAX5442/MAX5444 to code 32768 when V_{DD} is first applied. This ensures that unwanted DAC output voltages will not occur immediately following a system power-up, such as after a loss of power.

Applications Information

Reference and Ground Inputs

The MAX5441–MAX5444 operate with external voltage references from 2V to V_{DD} , and maintain 16-bit performance if certain guidelines are followed when selecting and applying the reference. Ideally, the reference's temperature coefficient should be less than 0.1ppm/ $^{\circ}C$ to maintain 16-bit accuracy to within 1LSB over the $-40^{\circ}C$ to $+85^{\circ}C$ extended temperature range. Since this converter is designed as an inverted R-2R voltage-mode DAC, the input resistance seen by the voltage reference is code-dependent. In unipolar mode, the worst-case input-resistance variation is from 11.5k Ω (at code 8555hex) to 200k Ω (at code 0000hex). The maximum change in load current for a 2.5V reference is $2.5V / 11.5k\Omega = 217\mu A$; therefore, the required load regulation is 7ppm/mA for a maximum error of 0.1LSB. This implies a reference output impedance of less than 18m Ω . In addition, the impedance of the signal path from the voltage reference to the reference input must be kept low because it contributes directly to the load-regulation error.

The requirement for a low-impedance voltage reference is met with capacitor bypassing at the reference inputs and ground. A 0.1 μF ceramic capacitor with short leads between REF and GND provides high-frequency bypassing. A surface-mount ceramic chip capacitor is preferred because it has the lowest inductance. An

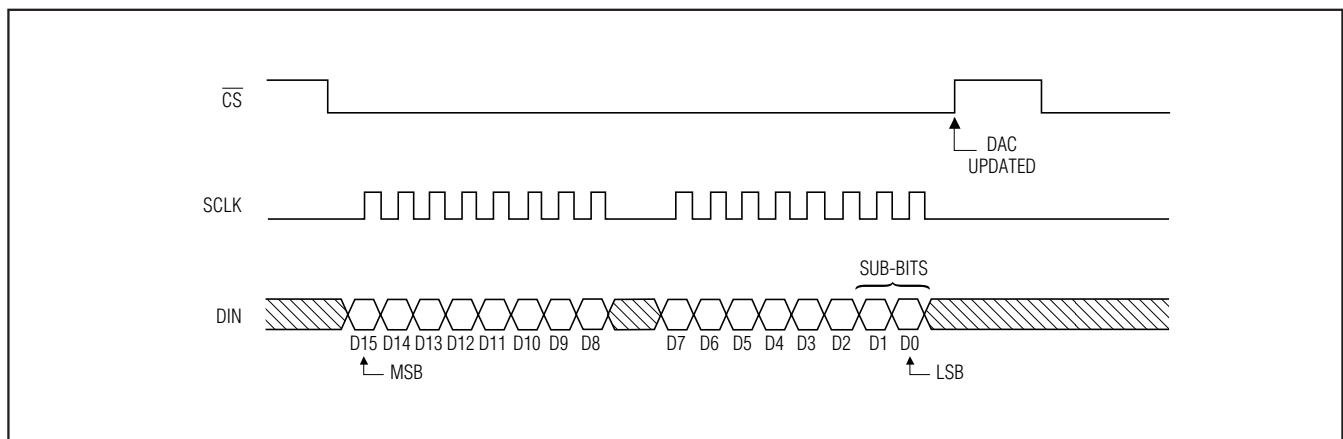


Figure 3. MAX5441–MAX5444 3-Wire Interface Timing Diagram

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additional 1 μ F between REF and GND provides low-frequency bypassing. A low-ESR tantalum, film, or organic semiconductor capacitor works well. Leaded capacitors are acceptable because impedance is not as critical at lower frequencies. The circuit can benefit from even larger bypassing capacitors, depending on the stability of the external reference with capacitive loading.

Unbuffered Operation

Unbuffered operation reduces power consumption as well as offset error contributed by the external output buffer. The R-2R DAC output is available directly at OUT, allowing 16-bit performance from +V_{REF} to GND without degradation at zero-scale. The DAC's output impedance is also low enough to drive medium loads ($R_L > 60k\Omega$) without degradation of INL or DNL; only the gain error is increased by externally loading the DAC output.

External Output Buffer Amplifier

The requirements on the external output buffer amplifier change whether the DAC is used in the unipolar or bipolar mode of operation. In unipolar mode, the output amplifier is used in a voltage-follower connection. In bipolar mode (MAX5442/MAX5444 only), the amplifier operates with the internal scaling resistors (Figure 2b). In each mode, the DAC's output resistance is constant and is independent of input code; however, the output amplifier's input impedance should still be as high as possible to minimize gain errors. The DAC's output capacitance is also independent of input code, thus simplifying stability requirements on the external amplifier.

In bipolar mode, a precision amplifier operating with dual power supplies (such as the MAX400) provides the $\pm V_{REF}$ output range. In single-supply applications, precision amplifiers with input common-mode ranges including GND are available; however, their output swings do not normally include the negative rail (GND) without significant degradation of performance. A single-supply op amp, such as the MAX495, is suitable if the application does not use codes near zero.

Since the LSBs for a 16-bit DAC are extremely small (38.15 μ V for $V_{REF} = 2.5V$), pay close attention to the external amplifier's input specification. The input offset voltage can degrade the zero-scale error and might require an output offset trim to maintain full accuracy if the offset voltage is greater than 1/2LSB. Similarly, the input bias current multiplied by the DAC output resistance (typically 6.25k Ω) contributes to the zero-scale error. Temperature effects also must be taken into consideration. Over the -40°C to +85°C extended temperature range, the offset voltage temperature coefficient (referenced to +25°C) must be less than 0.24 μ V/°C to

add less than 1/2LSB of zero-scale error. The external amplifier's input resistance forms a resistive divider with the DAC output resistance, which results in a gain error. To contribute less than 1/2LSB of gain error, the input resistance typically must be greater than:

$$6.25k\Omega \times 2^{17} = 819M\Omega$$

The settling time is affected by the buffer input capacitance, the DAC's output capacitance, and PC board capacitance. The typical DAC output voltage settling time is 1 μ s for a full-scale step. Settling time can be significantly less for smaller step changes. Assuming a single time-constant exponential settling response, a full-scale step takes 12 time constants to settle to within 1/2LSB of the final output voltage. The time constant is equal to the DAC output resistance multiplied by the total output capacitance. The DAC output capacitance is typically 10pF. Any additional output capacitance will increase the settling time.

The external buffer amplifier's gain-bandwidth product is important because it increases the settling time by adding another time constant to the output response. The effective time constant of two cascaded systems, each with a single time-constant response, is approximately the root square sum of the two time constants. The DAC output's time constant is 1 μ s / 12 = 83ns, ignoring the effect of additional capacitance. If the time constant of an external amplifier with 1MHz bandwidth is $1 / 2\pi (1MHz) = 159ns$, then the effective time constant of the combined system is:

$$\sqrt{[(83ns)^2 + (159ns)^2]} = 180ns$$

This suggests that the settling time to within 1/2LSB of the final output voltage, including the external buffer amplifier, will be approximately $12 \times 180ns = 2.15\mu s$.

Digital Inputs and Interface Logic

The digital interface for the 16-bit DAC is based on a 3-wire standard that is compatible with SPI, QSPI, and MICROWIRE interfaces. The three digital inputs (\overline{CS} , DIN, and SCLK) load the digital input data serially into the DAC.

A 20ns (min) logic-low pulse on \overline{CLR} clears the data in the DAC buffer.

All of the digital inputs include Schmitt-trigger buffers to accept slow-transition interfaces. This means that optocouplers can interface directly to the MAX5441-MAX5444 without additional external logic. The digital inputs are compatible with TTL/CMOS-logic levels.

+3V/+5V, Serial-Input, Voltage-Output, 16-Bit DACs

Unipolar Configuration

Figure 2a shows the MAX5441-MAX5444 configured for unipolar operation with an external op amp. The op amp is set for unity gain, and Table 1 lists the codes for this circuit. The bipolar MAX5442/MAX5444 can also be used in unipolar configuration by connecting RFB and INV to REF. This allows the DAC to power-up to mid-scale.

Bipolar Configuration

Figure 2b shows the MAX5442/MAX5444 configured for bipolar operation with an external op amp. The op amp is set for unity gain with an offset of $-1/2V_{REF}$. Table 2 lists the offset binary codes for this circuit.

Power-Supply Bypassing and Ground Management

Bypass V_{DD} with a $0.1\mu\text{F}$ ceramic capacitor connected between V_{DD} and GND. Mount the capacitor with short leads close to the device (less than 0.25 inches).

Table 1. Unipolar Code Table

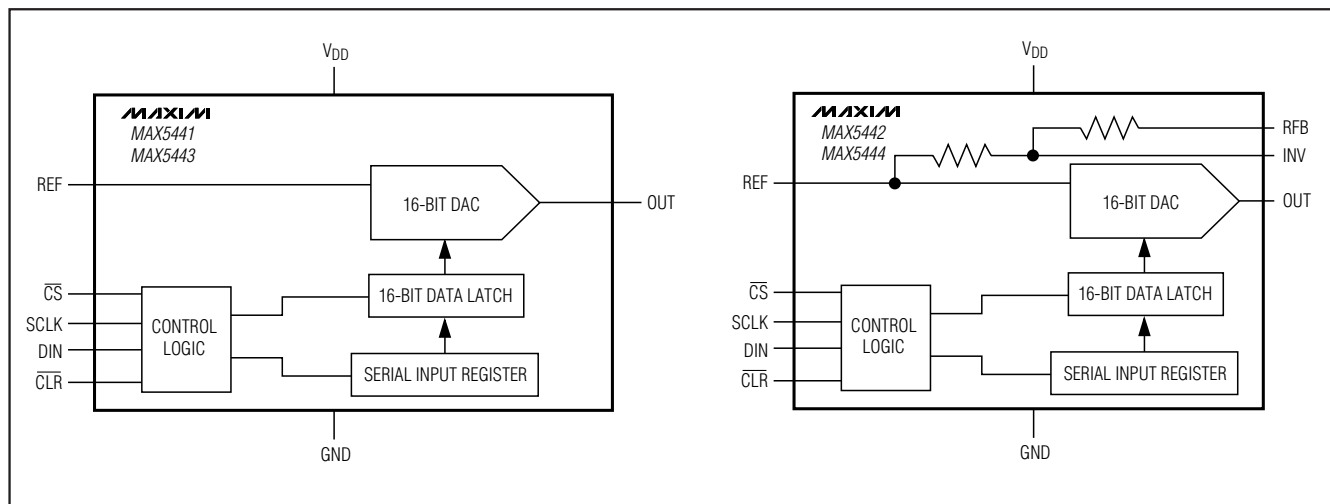
| DAC LATCH CONTENTS | | ANALOG OUTPUT, V_{OUT} |
|---------------------|-----|---|
| MSB | LSB | |
| 1111 1111 1111 1111 | | $V_{REF} \times (65,535 / 65,536)$ |
| 1000 0000 0000 0000 | | $V_{REF} \times (32,768 / 65,536) = 1/2V_{REF}$ |
| 0000 0000 0000 0001 | | $V_{REF} \times (1 / 65,536)$ |
| 0000 0000 0000 0000 | | 0 |

Table 2. Bipolar Code Table

| DAC LATCH CONTENTS | | ANALOG OUTPUT, V_{OUT} |
|---------------------|-----|--|
| MSB | LSB | |
| 1111 1111 1111 1111 | | $+V_{REF} \times (32,767 / 32,768)$ |
| 1000 0000 0000 0001 | | $+V_{REF} \times (1 / 32,768)$ |
| 1000 0000 0000 0000 | | 0 |
| 0111 1111 1111 1111 | | $-V_{REF} \times (1 / 32,768)$ |
| 0000 0000 0000 0000 | | $-V_{REF} \times (32,768 / 32,768) = -V_{REF}$ |

+3V/+5V, Serial-Input, Voltage-Output, 16-Bit DACs

Functional Diagrams



MAX5441-MAX5444

Ordering Information (continued)

| PART | TEMP RANGE | PIN-PACKAGE | INL (LSB) | SUPPLY (V) |
|---------------------|----------------|--------------|-----------|------------|
| MAX5443 ACUA | 0°C to +70°C | 8 μ MAX | ± 2 | 3 |
| MAX5443AEUA | -40°C to +85°C | 8 μ MAX | ± 2 | 3 |
| MAX5443BCUA | 0°C to +70°C | 8 μ MAX | ± 4 | 3 |
| MAX5443BEUA | -40°C to +85°C | 8 μ MAX | ± 4 | 3 |
| MAX5444 ACUB | 0°C to +70°C | 10 μ MAX | ± 2 | 3 |
| MAX5444AEUB | -40°C to +85°C | 10 μ MAX | ± 2 | 3 |
| MAX5444BCUB | 0°C to +70°C | 10 μ MAX | ± 4 | 3 |
| MAX5444BEUB | -40°C to +85°C | 10 μ MAX | ± 4 | 3 |

Chip Information

TRANSISTOR COUNT: 2800
PROCESS: BICMOS

Package Information

For the latest package outline information, go to www.maxim-ic.com/packages.

| PACKAGE TYPE | PACKAGE CODE | DOCUMENT NO. |
|--------------|--------------|-------------------------|
| 8 μ MAX | U8-1 | 21-0036 |
| 10 μ MAX | U10-2 | 21-0061 |

+3V/+5V, Serial-Input, Voltage-Output, 16-Bit DACs

Revision History

| REVISION NUMBER | REVISION DATE | DESCRIPTION | PAGES CHANGED |
|-----------------|---------------|------------------------|---------------|
| 0 | 10/00 | Initial release | — |
| 2 | 10/07 | Changed timing diagram | 6 |

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